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 PTO/SB/08A (10-96)  
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| Substitute for form 1449A/PTO<br>(Modified by BSTZ 6/30/99)<br><br><b>INFORMATION DISCLOSURE<br/>STATEMENT BY APPLICANT</b><br><br>(use as many sheets as necessary) |                  |   |   | Complete if Known    |                  |
|  |                  |   |   | Application Number   | Not Yet Assigned |
|  |                  |   |   | Filing Date          | Herewith         |
|  |                  |   |   | First Named Inventor | Yougeng Wu       |
|  |                  |   |   | Group Art Unit       | 2122             |
| Examiner Name  | Not yet Assigned | 11000 U.S. PTO<br>09/818688<br>03/26/01 |   |                      |                  |
| Attorney Docket Number   | 42390P10788      |   |   |                      |                  |
| Sheet  | 1                | of                                      | 1 |                      |                  |

| U.S. PATENT DOCUMENTS  |                      |  |  |  |                            |
|------------------------|----------------------|--|--|--|----------------------------|
| Examiner<br>Initials * | U.S. Patent Document |  | Name of Patentee or Applicant<br>of Cited Document | Date of Publication of<br>Cited Document<br>MM-DD-YYYY | Filing Date if Appropriate |
|                        | Number               |  |  |  |                            |
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| FOREIGN PATENT DOCUMENTS |                         |        |      |  |  |                        |
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| Examiner<br>Initials *   | Foreign Patent Document |        |      | Name of Patentee or Applicant<br>of Cited Document | Date of Publication of<br>Cited Document<br>MM-DD-YYYY | Translation?<br>Yes/No |
|                          | Office or Country       | Number | Date |  |  |                        |
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| OTHER DOCUMENTS        |  |                        |
|------------------------|--|------------------------|
| Examiner<br>Initials * | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published (if known). | Translation?<br>Yes/No |
|                        | <del>WU, YOUNG FENG, ET AL., "An Efficient Software-Hardware Collaborative Profiling Technique for Wide-Issue Processors," No Date, Pages 1-9, Microprocessor Research Lab, Intel Corporation, Santa Clara, USA.</del>   |                        |
| TTV                    | MERTEN C. MATTHEW, ET AL., "A Hardware-Driven Profiling Scheme for Identifying Program Hot Spots to Support Runtime Optimization", May 1999, Pages 134-147, 26th Annual Intl. Symposium on Computer Architecture, Urbana, IL   |                        |
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|-----------------------|-----------|--------------------|--------|
| Examiner<br>Signature | TED T. VO | Date<br>Considered | 9/22/3 |
|-----------------------|-----------|--------------------|--------|

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